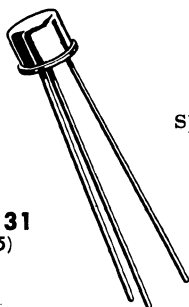


**2N3013****2N3014**

For Specifications, See 2N3009 Data.

**2N3015 (SILICON)****CASE 31**  
(TO-5)

NPN silicon annular transistor designed for high-speed, medium-power saturated switching applications.

Collector connected to case

**MAXIMUM RATINGS** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

Rating	Symbol	Value	Unit
Collector-Emitter Voltage*	$V_{CEO}^*$	30	Vdc
Collector-Base Voltage	$V_{CB}$	60	Vdc
Emitter-Base Voltage	$V_{EB}$	5.0	Vdc
Total Device Dissipation @ $T_A = 25^\circ\text{C}$ Derate above $25^\circ\text{C}$	$P_D$	800 4.6	mW mW/ $^\circ\text{C}$
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above $25^\circ\text{C}$	$P_D$	3.0 17.2	Watts mW/ $^\circ\text{C}$
Operating and Storage Junction Temperature Range	$T_J, T_{stg}$	-65 to +200	$^\circ\text{C}$

\*Applicable from 1.0 mA to 30 mA (Pulsed)

# 2N3015 (continued)

## ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
<b>OFF CHARACTERISTICS</b>				
Collector-Emitter Sustaining Voltage* (I <sub>C</sub> = 30 mA, I <sub>B</sub> = 0)	BV <sub>CEO(sus)</sub> *	30	—	Vdc
Collector-Base Breakdown Voltage (I <sub>C</sub> = 100 μA, I <sub>E</sub> = 0)	BV <sub>CB0</sub>	60	—	Vdc
Emitter-Base Breakdown Voltage (I <sub>E</sub> = 100 μA, I <sub>C</sub> = 0)	BV <sub>EBO</sub>	5.0	—	Vdc
Collector-Cutoff Current (V <sub>CE</sub> = 30 Vdc, V <sub>BE</sub> = 0)	I <sub>CES</sub>	—	0.2	μA
Collector-Cutoff Current (V <sub>CB</sub> = 30 Vdc, I <sub>E</sub> = 0, T <sub>A</sub> = 125°C)	I <sub>CBO</sub>	—	200	μA
Base Leakage Current (V <sub>CE</sub> = 30 Vdc, V <sub>BE</sub> = 0)	I <sub>BL</sub>	—	0.2	μA

## ON CHARACTERISTICS

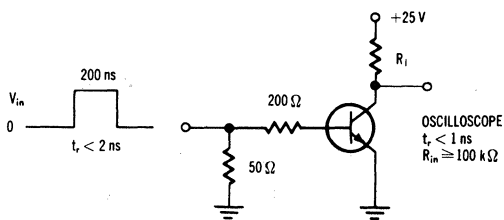
DC Current Gain* (I <sub>C</sub> = 150 mA, V <sub>CE</sub> = 10 Vdc) (I <sub>C</sub> = 300 mA, V <sub>CE</sub> = 0.7 Vdc)	h <sub>FE</sub> *	30 10	120 —	—
Collector-Emitter Saturation Voltage* (I <sub>C</sub> = 150 mA, I <sub>B</sub> = 15 mA) (I <sub>C</sub> = 500 mA, I <sub>B</sub> = 50 mA)	V <sub>CE(sat)</sub> *	— —	0.4 1.0	Vdc
Base-Emitter Saturation Voltage* (I <sub>C</sub> = 150 mA, I <sub>B</sub> = 15 mA) (I <sub>C</sub> = 500 mA, I <sub>B</sub> = 50 mA)	V <sub>BE(sat)</sub> *	— —	1.2 1.6	Vdc

## DYNAMIC CHARACTERISTICS

Current-Gain-Bandwidth Product (I <sub>C</sub> = 50 mA, V <sub>CE</sub> = 10 Vdc, f = 100 MHz)	f <sub>T</sub>	250	—	MHz
Output Capacitance (V <sub>CB</sub> = 10 Vdc, I <sub>E</sub> = 0, f = 140 kHz)	C <sub>ob</sub>	—	8.0	pF
Turn-On Time (Figure 1) (V <sub>CC</sub> = 25 Vdc, I <sub>C</sub> ≈ 300 mA, I <sub>B1</sub> ≈ 30 mA) (V <sub>CC</sub> = 25 Vdc, I <sub>C</sub> ≈ 500 mA, I <sub>B1</sub> ≈ 50 mA)	t <sub>on</sub>	— —	40 40	ns
Turn-Off Time (Figure 2) (V <sub>CC</sub> = 25 Vdc, I <sub>C</sub> ≈ 300 mA, I <sub>B1</sub> ≈ I <sub>B2</sub> = 30 mA) (V <sub>CC</sub> = 25 Vdc, I <sub>C</sub> ≈ 500 mA, I <sub>B1</sub> ≈ I <sub>B2</sub> = 50 mA)	t <sub>off</sub>	— —	60 60	ns

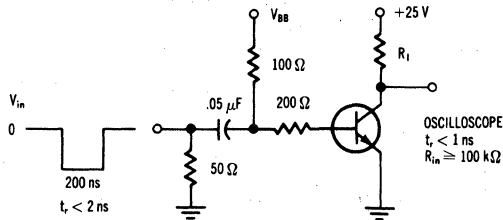
\*Pulse Test: Pulse Width = 300 μs; Duty Cycle ≤ 2%

FIGURE 1 — TURN-ON TIME TEST CIRCUIT



I <sub>C</sub> mA	V <sub>in</sub> Volts	R <sub>i</sub> ohms
300	7.0	80
500	11	48

FIGURE 2 — TURN-OFF TIME TEST CIRCUIT



I <sub>C</sub> mA	V <sub>in</sub> Volts	V <sub>BB</sub> Volts	R <sub>i</sub> ohms
300	-13	10	80
500	-21	16	48